Se	earch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/710,366	CHEN, HENG-CHIEN
Examiner	Art Unit
Lina Yang	2665

	SEARCHED		
Class	Subclass	Date	Examiner
370	328,338 352,401 254	5/11/2005	LY
,			
		:	
		·	
	,		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		-		
	1			
			·	

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST	5/11/2005	LY
Counsulted Steven NGUYEN	5/12/2005	LY
•		
		i i
·		